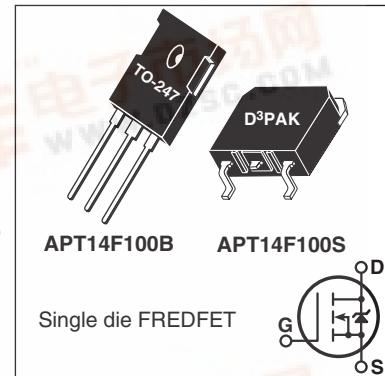



**APT14F100B
APT14F100S**
1000V, 14A, 1.00Ω Max, t_{rr} ≤ 240ns

N-Channel FREDFET

Power MOS 8™ is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced t_{rr}, soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C_{rss}/C_{iss} result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



FEATURES

- Fast switching with low EMI
- Low t_{rr} for high reliability
- Ultra low C_{rss} for improved noise immunity
- Low gate charge
- Avalanche energy rated
- RoHS compliant

TYPICAL APPLICATIONS

- ZVS phase shifted and other full bridge
- Half bridge
- PFC and other boost converter
- Buck converter
- Single and two switch forward
- Flyback

Absolute Maximum Ratings

Symbol	Parameter	Ratings	Unit
I _D	Continuous Drain Current @ T _C = 25°C	14	A
	Continuous Drain Current @ T _C = 100°C	9	
I _{DM}	Pulsed Drain Current ^①	55	
V _{GS}	Gate-Source Voltage	±30	V
E _{AS}	Single Pulse Avalanche Energy ^②	875	mJ
I _{AR}	Avalanche Current, Repetitive or Non-Repetitive	7	A

Thermal and Mechanical Characteristics

Symbol	Characteristic	Min	Typ	Max	Unit
P _D	Total Power Dissipation @ T _C = 25°C			500	W
R _{θJC}	Junction to Case Thermal Resistance			0.25	°C/W
R _{θCS}	Case to Sink Thermal Resistance, Flat, Greased Surface		0.11		
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55		150	°C
T _L	Soldering Temperature for 10 Seconds (1.6mm from case)			300	
W _T	Package Weight		0.22		oz
			6.2		g
Torque	Mounting Torque (TO-247 Package), 6-32 or M3 screw			10	in-lbf
				1.1	N·m

Static Characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified

APT14F100B_S

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
$V_{BR(DSS)}$	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu\text{A}$	1000			V
$\Delta V_{BR(DSS)}/\Delta T_J$	Breakdown Voltage Temperature Coefficient	Reference to $25^\circ\text{C}, I_D = 250\mu\text{A}$		1.15		$\text{V}/^\circ\text{C}$
$R_{DS(on)}$	Drain-Source On Resistance ^③	$V_{GS} = 10V, I_D = 7A$		0.84	1.00	Ω
$V_{GS(th)}$	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 1\text{mA}$	3	4	5	V
$\Delta V_{GS(th)}/\Delta T_J$	Threshold Voltage Temperature Coefficient			-10		$\text{mV}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 1000V, T_J = 25^\circ\text{C}$			250	μA
		$V_{GS} = 0V, T_J = 125^\circ\text{C}$			1000	
I_{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 30V$			± 100	nA

Dynamic Characteristics

$T_J = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
g_{fs}	Forward Transconductance	$V_{DS} = 50V, I_D = 7A$		16		S
C_{iss}	Input Capacitance			3965		pF
C_{rss}	Reverse Transfer Capacitance			55		
C_{oss}	Output Capacitance			335		
$C_{o(cr)}^{\text{④}}$	Effective Output Capacitance, Charge Related	$V_{GS} = 0V, V_{DS} = 25V$ $f = 1\text{MHz}$		135		pF
$C_{o(er)}^{\text{⑤}}$	Effective Output Capacitance, Energy Related			70		
Q_g	Total Gate Charge	$V_{GS} = 0$ to $10V, I_D = 7A,$ $V_{DS} = 500V$		120		nC
Q_{gs}	Gate-Source Charge			21		
Q_{gd}	Gate-Drain Charge			60		
$t_{d(on)}$	Turn-On Delay Time	Resistive Switching $V_{DD} = 667V, I_D = 7A$ $R_G = 4.7\Omega^{\text{⑥}}$, $V_{GG} = 15V$		28		ns
t_r	Current Rise Time			29		
$t_{d(off)}$	Turn-Off Delay Time			95		
t_f	Current Fall Time			26		

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
I_s	Continuous Source Current (Body Diode)	MOSFET symbol showing the integral reverse p-n junction diode (body diode)			14	A
I_{SM}	Pulsed Source Current (Body Diode) ^①				56	
V_{SD}	Diode Forward Voltage	$I_{SD} = 7A, T_J = 25^\circ\text{C}, V_{GS} = 0V$			1.0	V
t_{rr}	Reverse Recovery Time	$I_{SD} = 7A^{\text{③}}$ $di_{SD}/dt = 100A/\mu\text{s}$ $V_{DD} = 100V$	$T_J = 25^\circ\text{C}$	205	240	ns
Q_{rr}	Reverse Recovery Charge		$T_J = 125^\circ\text{C}$	355	430	
I_{rrm}	Reverse Recovery Current		$T_J = 25^\circ\text{C}$	0.90		μC
			$T_J = 125^\circ\text{C}$	2.20		
			$T_J = 25^\circ\text{C}$	8.90		A
			$T_J = 125^\circ\text{C}$	12.90		
dv/dt	Peak Recovery dv/dt	$I_{SD} \leq 7A, di/dt \leq 1000A/\mu\text{s}, V_{DD} = 400V, T_J = 125^\circ\text{C}$			25	V/ns

① Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

② Starting at $T_J = 25^\circ\text{C}$, $L = 35.71\text{mH}$, $R_G = 25\Omega$, $I_{AS} = 7A$.

③ Pulse test: Pulse Width < 380 μs , duty cycle < 2%.

④ $C_{o(cr)}$ is defined as a fixed capacitance with the same stored charge as C_{OSS} with $V_{DS} = 67\%$ of $V_{(BR)DSS}$.

⑤ $C_{o(er)}$ is defined as a fixed capacitance with the same stored energy as C_{OSS} with $V_{DS} = 67\%$ of $V_{(BR)DSS}$. To calculate $C_{o(er)}$ for any value of V_{DS} less than $V_{(BR)DSS}$, use this equation: $C_{o(er)} = -1.15E-7/V_{DS}^2 + 2.03E-8/V_{DS} + 3.93E-11$.

⑥ R_G is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

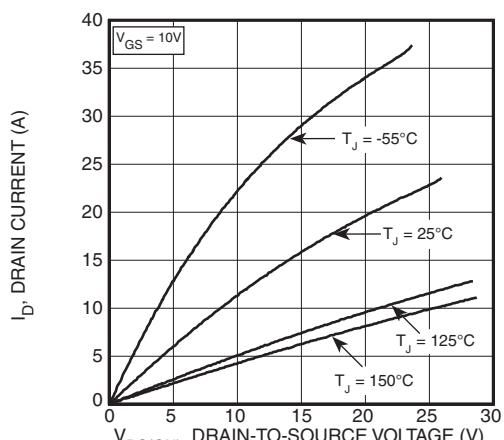


Figure 1, Output Characteristics

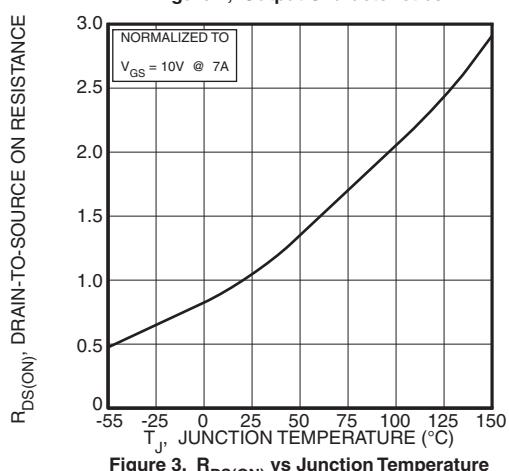


Figure 3, $R_{DS(ON)}$ vs Junction Temperature

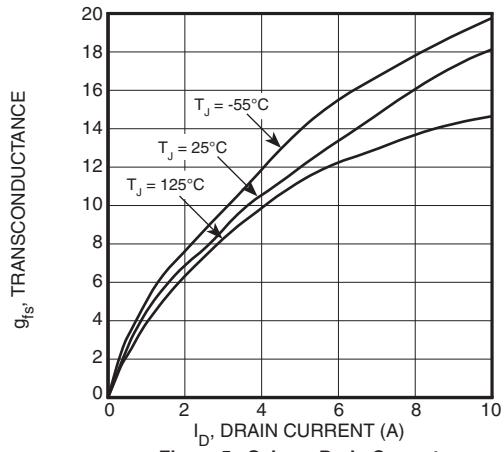


Figure 5, Gain vs Drain Current

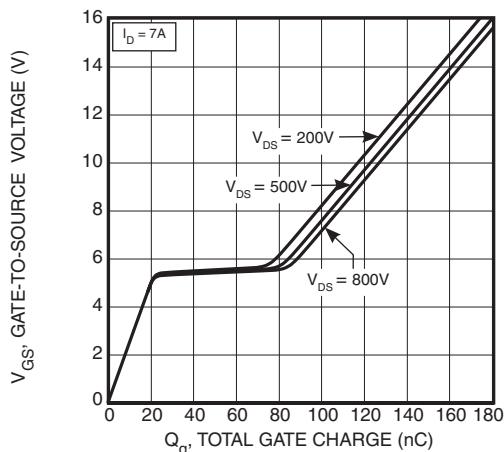


Figure 7, Gate Charge vs Gate-to-Source Voltage

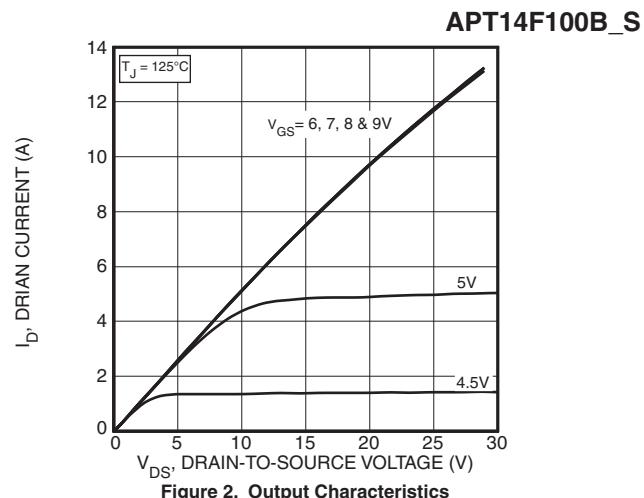


Figure 2, Output Characteristics

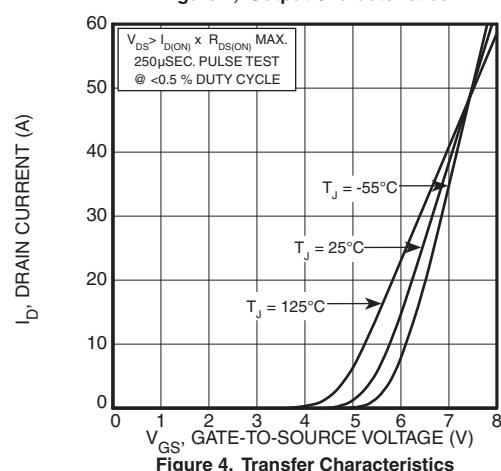


Figure 4, Transfer Characteristics

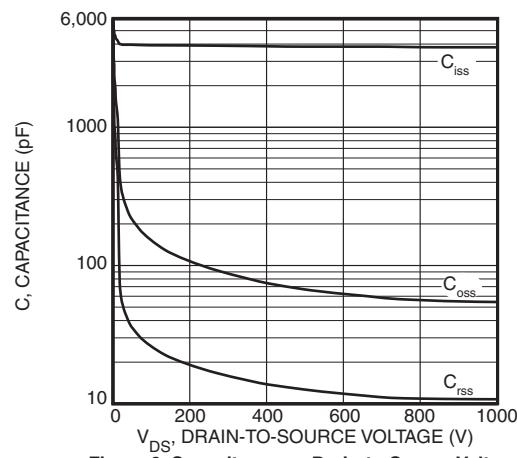


Figure 6, Capacitance vs Drain-to-Source Voltage

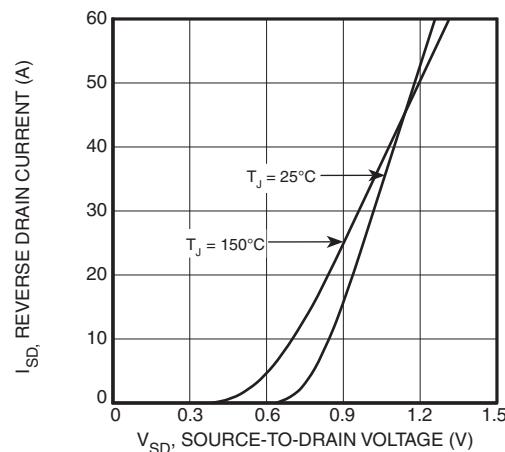


Figure 8, Reverse Drain Current vs Source-to-Drain Voltage

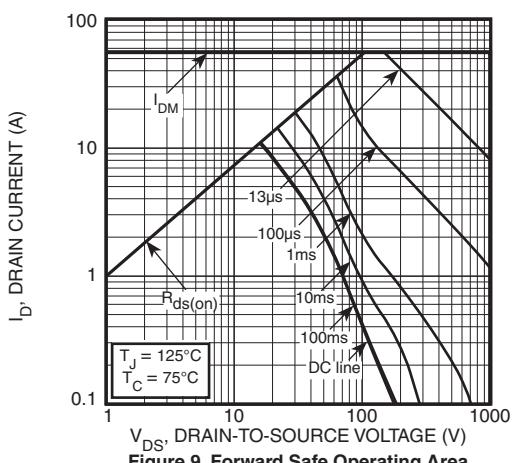


Figure 9, Forward Safe Operating Area

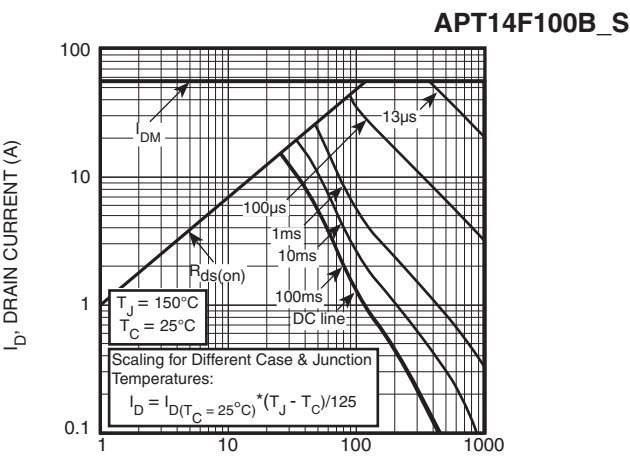


Figure 10, Maximum Forward Safe Operating Area

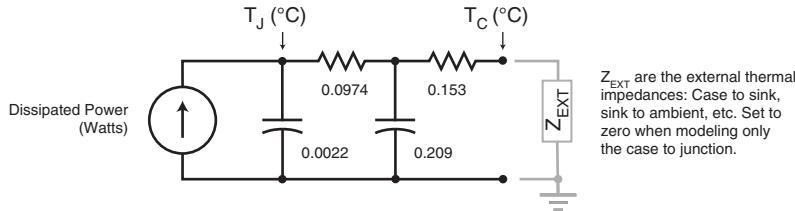


Figure 11, Transient Thermal Impedance Model

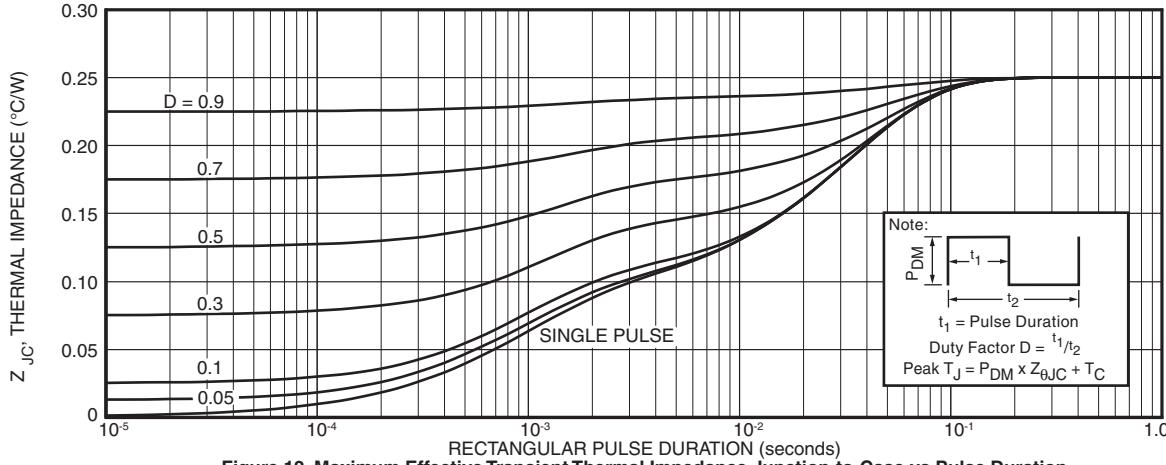
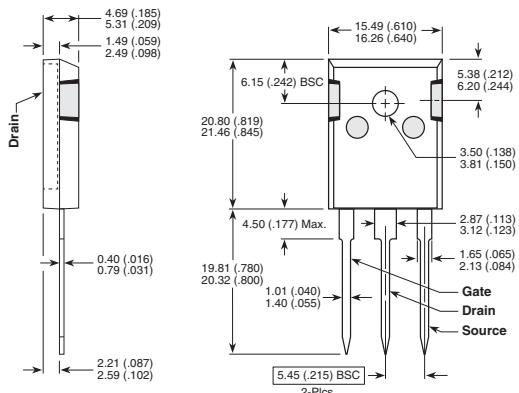


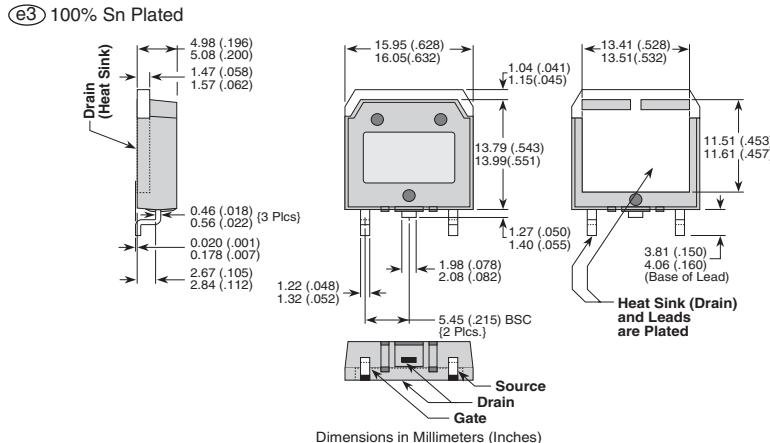
Figure 12. Maximum Effective Transient Thermal Impedance Junction-to-Case vs Pulse Duration

TO-247 (B) Package Outline



Dimensions in Millimeters (Inches)

D³PAK Package Outline



Dimensions in Millimeters (Inches)